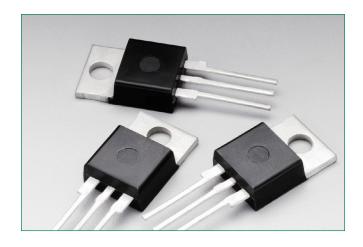
Sensitive Gate Silicon Controlled Rectifiers — 400V - 800V





### **Additional Information**



Resources





Accessories

Samples

#### **Functional Diagram**



## **Description**

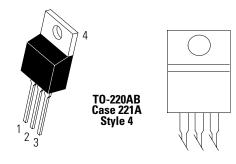
Designed primarily for half-wave ac control applications, such as motor controls, heating controls, and power supplies; or wherever half-wave, silicon gate-controlled devices are needed.

## **Features**

- Sensitive Gate Allows
  Triggering by Microcontrollers
  and other Logic Circuits
- Blocking Voltage to 800 V
- On-State Current Rating of 8 A RMS at 80°C
- High Surge Current Capability80 A
- Rugged, Economical TO-220AB Package

- Glass Passivated Junctions for Reliability and Uniformity
- Minimum and Maximum Values of IGT, VGT and IH Specified for Ease of Design
- Immunity to dv/dt 5 V/μsec Minimum at 110°C
- These are Pb-Free Devices

### **Pin Out**





Sensitive Gate Silicon Controlled Rectifiers — 400V - 800V

### **Maximum Ratings** $(T_j = 25^{\circ}C \text{ unless otherwise noted})$

Rating		Symbol	Value	Unit
Peak Repetitive Off-State Voltage (Note 1) (- 40 to 110°C, Sine Wave, 50 to 60 Hz, Gate Open)	MCR8SDG MCR8SMG MCR8SNG	V <sub>DRM</sub> , V <sub>RRM</sub>	400 600 800	V
On-State RMS Current (180° Conduction Angles; $T_c = 80$ °C)		I <sub>T (RMS)</sub>	8.0	А
Peak Non-Repetitive Surge Current (1/2 Cycle, Sine Wave 60 Hz, T <sub>J</sub> = 110°C)		I <sub>TSM</sub>	80	А
Circuit Fusing Consideration (t = 8.33 ms)		l²t	26.5	A²sec
Forward Peak Gate Power (Pulse Width $\leq$ 10 $\mu$ sec, $T_{\rm C}$ = 80°C)		$P_{GM}$	5.0	W
Forward Average Gate Power (t = 8.3 msec, $T_c = 80$ °C)		P <sub>GM (AV)</sub>	0.5	W
Forward Peak Gate Current (Pulse Width $\leq$ 10 $\mu$ sec, $T_c$ = 80°C)		I <sub>GM</sub>	2.0	А
Operating Junction Temperature Range		T <sub>J</sub>	-40 to 110	°C
Storage Temperature Range		T <sub>stg</sub>	-40 to 150	°C

Stresses exceeding Maximum Ratings may damage the device. Maximum Ratings are stress ratings only. Functional operation above the Recommended Operating Conditions is not implied. Extended exposure to stresses above the Recommended Operating Conditions may affect device reliability.

#### **Thermal Characteristics**

Rating	Symbol	Value	Unit
Thermal Resistance, Junction-to-Case	R <sub>sJC</sub>	2.2	°C/W
Thermal Resistance, Junction-to-Ambient	R <sub>8JA</sub>	62.5	C/VV
Maximum Lead Temperature for Soldering Purposes 1/8" from Case for 10 Seconds	T <sub>L</sub>	260	°C

## **Electrical Characteristics - OFF** $(T_J = 25^{\circ}\text{C unless otherwise noted})$

Characteristic		Symbol	Min	Тур	Max	Unit
Peak Repetitive Forward or Reverse Blocking Current (Note 3)	$T_{J} = 25^{\circ}C$	I <sub>DRM</sub> ,	-	-	10	
$(V_{AK} = Rated V_{DRM} \text{ or } V_{RRM'} R_{GK} = 1.0 \text{ k}\Omega$	T <sub>1</sub> = 110°C	I	-	-	500	μΑ

## **Electrical Characteristics - ON** $(T_J = 25^{\circ}\text{C unless otherwise noted; Electricals apply in both directions)$

Characteristic		Symbol	Min	Тур	Max	Unit
Peak Forward On-State Voltage (Note 2) (I <sub>TM</sub> = 16 A)		$V_{TM}$	-	-	1.8	V
Gate Trigger Current (Continuous dc) (Note 4) $(V_D = 12 \text{ V}; R_L = 100 \Omega)$		I <sub>GT</sub>	5.0	25	200	μΑ
Holding Current (Note 3) (V <sub>p</sub> = 12 V, Gate Open, Initiating Current = 200 mA)		I <sub>H</sub>	-	0.5	6.0	mA
Latch Current (Note 4) ( $V_p = 12 \text{ V}, I_g = 200 \mu\text{A}$ )		I	-	0.6	8.0	mA
Gate Trigger Voltage (Continuous dc) $(V_D = 12 \text{ V}, R_I = 100 \Omega)$	T <sub>J</sub> = 25°C	\/	0.3	0.65	1.0	V
(Note 4)	$T_J = -40^{\circ}C$	$V_{\rm GT}$	-	-	1.5	V
Gate Non-Trigger Voltage $(V_D = 12 \text{ V}, \text{ R}_1 = 100 \Omega)$	T <sub>J</sub> = 110°C	$V_{\rm GD}$	0.2	-	-	V



<sup>1.</sup> V<sub>DBM</sub> and V<sub>SBM</sub> for all types can be applied on a continuous basis. Ratings apply for zero or negative gate voltage; however, positive gate voltage shall not be applied concurrent with negative potential on the anode. Blocking voltages shall not be tested with a constant current source such that the voltage ratings of the devices are exceeded.

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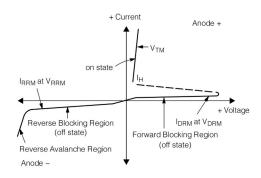
#### **Dynamic Characteristics**

Characteristic	Symbol	Min	Тур	Max	Unit
Critical Rate of Rise of Off–State Voltage ( $V_D = 67\% V_{DRM'} R_{GK} = 1 K\Omega, C_{GK} = 0.1 \mu F, T_J = 110^{\circ}C$ )	dv/dt	5.0	15	_	V/µs
Critical Rate of Rise of On-State Current (IPK = 50 A, Pw = 40 µsec, diG/dt = 1 A/µsec, lgt = 10 mA	di/dt	_	_	100	A/µs

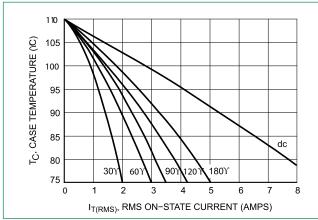
Product parametric performance is indicated in the Electrical Characteristics for the listed test conditions, unless otherwise noted. Product performance may not be indicated by the Electrical Characteristics if operated under different conditions.

## **Voltage Current Characteristic of SCR**

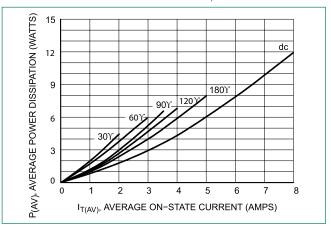
Symbol	Parameter
$V_{DRM}$	Peak Repetitive Forward Off State Voltage
I <sub>DRM</sub>	Peak Forward Blocking Current
$V_{RRM}$	Peak Repetitive Reverse Off State Voltage
I <sub>RRM</sub>	Peak Reverse Blocking Current
$V_{TM}$	Maximum On State Voltage
I <sub>u</sub>	Holding Current



**Figure 1.**Typical RMS Current Derating



**Figure 2.** On–State Power Dissipation



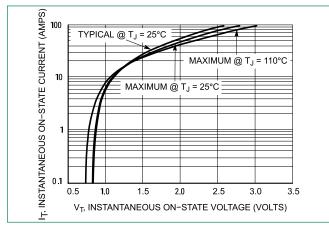
<sup>2.</sup> Ratings apply for negative gate voltage or RGK = 1.0 kQ. Devices shall not have a positive gate voltage concurrently with a negative voltage on the anode. Devices should not be tested with a constant current source for forward and reverse blocking capability such that the voltage applied exceeds the rated blocking voltage.

<sup>3.</sup> Pulse Test; Pulse Width  $\leq$  2.0 msec, Duty Cycle  $\leq$  2%.

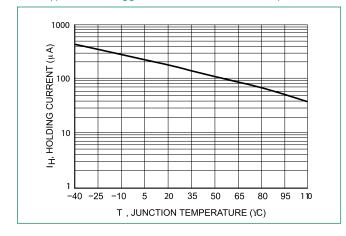
<sup>4.</sup> RGK current not included in measurements.

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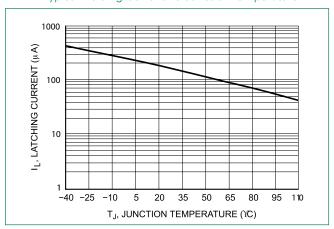
**Figure 3.** Typical On–State Characteristics



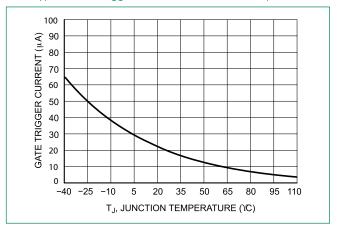
**Figure 5.**Typical Gate Trigger Current vs Junction Temperature



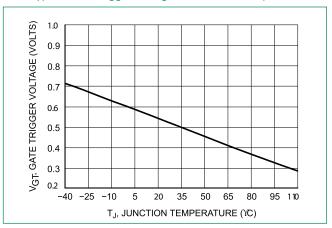
**Figure 7.**Typical Holding Current vs Junction Temperature



**Figure 4.**Typical Gate Trigger Current vs Junction Temperature

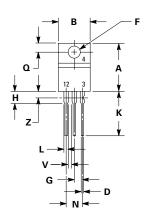


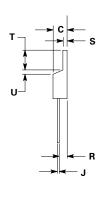
**Figure 6.**Typical Gate Trigger Voltage vs Junction Temperature



Sensitive Gate Silicon Controlled Rectifiers — 400V - 800V

#### **Dimensions**





	Т0-	220AB	YMAXX MCR8SxG AKA
1 2 3	Y M A AKA G	=Year =Month =Assembly Site =Diode Polarity =Pb-Free Package	

**Part Marking System** 

Dim	Inches		Millin	neters
DIM	Min	Max	Min	Max
Α	0.590	0.620	14.99	15.75
В	0.380	0.420	9.65	10.67
С	0.178	0.188	4.52	4.78
D	0.025	0.035	0.64	0.89
F	0.142	0.147	3.61	3.73
G	0.095	0.105	2.41	2.67
Н	0.110	0.130	2.79	3.30
J	0.018	0.024	0.46	0.61
K	0.540	0.575	13.72	14.61
L	0.060	0.075	1.52	1.91
N	0.195	0.205	4.95	5.21
Q	0.105	0.115	2.67	2.92
R	0.085	0.095	2.16	2.41
S	0.045	0.060	1.14	1.52
Т	0.235	0.255	5.97	6.47
U	0.000	0.050	0.00	1.27
V	0.045		1.15	_
Z		0.080		2.04

Pin Assignment			
1	Cathode		
2	Anode		
3	Gate		
4	Anode		

### **Ordering Information**

Device	Package	Shipping
MCR8SDG		
MCR8SMG	TO-220AB (Pb-Free)	1000 Units / Box
MCR8SNG	(. 2 1100)	



Disclaimer Notice - Information furnished is believed to be accurate and reliable. However, users should independently evaluate the suitability of and test each product selected for their own applications. Littelfuse products are

Dimensioning and tolerancing per ansi γ14.5m, 1982.
 Controlling dimension: inch.
 Dimension z defines a zone where all body and lead irregularities are allowed.